Search Notes

Application/Control No.	
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10/630,846 Examiner

Art Unit

Applicant(s)/Patent under Reexamination HADLEY, MARC J.

Djenane M. Bayard

	SEARCHED					
Class	Subclass	Date	Examiner			
709	203	12/30/2006	DB			
715	522	12/30/2006	DB			
709	230	12/30/2006	DB			

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